

Search Notes

Application/Control No.

10/779,841

Examiner

Seyed Azarian

Applicant(s)/Patent under
Reexamination

TAKEO, HIDEYA

Art Unit

2624

SEARCHED

Class	Subclass	Date	Examiner
382	128,129 130,131 132	4/2/2007	S.A
382	168,172	4/2/2007	S.A
382	203,232	4/2/2007	S.A
382	260,274	4/2/2007	S.A
382	275,276	4/2/2007	S.A
382	305,308	4/2/2007	S.A
378	62,4,37	4/2/2007	S.A

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
INVENTOR SEARCH	4/2/2007	S.A
EAST SEARCH	4/2/2007	S.A
IEEE/NPL SEARCH	4/2/2007	S.A